

August 1986 Revised March 2000

DM74LS240 • DM74LS241 Octal 3-STATE Buffer/Line Driver/Line Receiver

General Description

These buffers/line drivers are designed to improve both the performance and PC board density of 3-STATE buffers/drivers employed as memory-address drivers, clock drivers, and bus-oriented transmitters/receivers. Featuring 400 mV of hysteresis at each low current PNP data line input, they provide improved noise rejection and high fanout outputs and can be used to drive terminated lines down to 133Ω .

Features

- 3-STATE outputs drive bus lines directly
- \blacksquare PNP inputs reduce DC loading on bus lines
- Hysteresis at data inputs improves noise margins
- Typical I_{OL} (sink current) 24 mA
- Typical I_{OH} (source current)
 - _15 mA

Noninverting

■ Typical propagation delay times

Inverting 10.5 ns

12 ns

- Typical enable/disable time 18 ns
- Typical power dissipation (enabled)

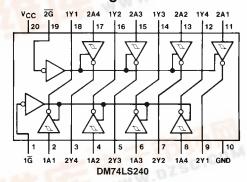
Inverting 130 mW Noninverting 135 mW

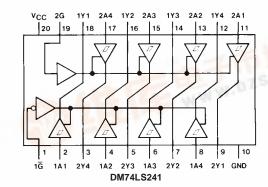
Ordering Code:

Order Number	Package Number	Package Description
DM74LS240WM	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
DM74LS240SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
DM74LS240N	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
DM74LS241WM	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
DM74LS241N	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagrams





Function Tables

DM74LS240

Inp	Output	
G	Α	Y
L	L	Н
L	Н	L
Н	Х	Z

DM74LS241

Inputs				Out	puts
G	G	1A	2A	1Y	2Y
Х	L	L	Х	L	
X	L	Н	Х	Н	
X	Н	X	X	Z	
Н	X	X	L		L
Н	Х	Х	Н		Н
L	Х	Х	Х		Z

- L = LOW Logic Level H = HIGH Logic Level X = Either LOW or HIGH Logic Level Z = High Impedance

Absolute Maximum Ratings(Note 1)

Supply Voltage 7V
Input Voltage 7V
Operating Free Air Temperature Range $0^{\circ}\text{C to } +70^{\circ}\text{C}$ Storage Temperature Range $-65^{\circ}\text{C to } +150^{\circ}\text{C}$

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Recommended Operating Conditions

Symbol	Parameter	Min	Nom	Max	Units
V _{CC}	Supply Voltage	4.75	5	5.25	V
V _{IH}	HIGH Level Input Voltage	2			V
V _{IL}	LOW Level Input Voltage			0.8	V
I _{OH}	HIGH Level Output Current			–15	mA
I _{OL}	LOW Level Output Current			24	mA
T _A	Free Air Operating Temperature	0		70	°C

Electrical Characteristics

over recommended operating free air temperature range (unless otherwise noted)

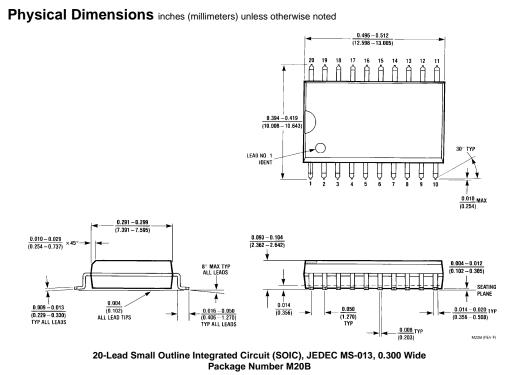
Symbol	Parameter	Cond	ditions	Min	Typ (Note 2)	Max	Units
VI	Input Clamp Voltage	$V_{CC} = Min, I_I = -18$	mA			-1.5	V
HYS	Hysteresis (V _{T+} – V _{T-}) Data Inputs Only	V _{CC} = Min		0.2	0.4		V
V _{OH}	HIGH Level Output Voltage	$V_{CC} = Min, V_{IH} = M$ $V_{IL} = Max, I_{OH} = -1$		2.7			
			$V_{CC} = Min, V_{IH} = Min$ $V_{IL} = Max, I_{OH} = -3 \text{ mA}$		3.4		V
		$V_{CC} = Min, V_{IH} = M$ $V_{IL} = 0.5V, I_{OH} = Ms$		2			
V _{OL}	LOW Level Output Voltage	V _{CC} = Min	I _{OL} = 12 mA			0.4	
		$V_{IL} = Max$ $V_{IH} = Min$	I _{OL} = Max			0.5	V
I _{OZH}	Off-State Output Current, HIGH Level Voltage Applied	$V_{CC} = Max$ $V_{IL} = Max$	V _O = 2.7V			20	μА
I _{OZL}	Off-State Output Current, LOW Level Voltage Applied	V _{IH} = Min	V _O = 0.4V			-20	μА
I _I	Input Current at Maximum Input Voltage	$V_{CC} = Max$ $V_{I} = 7V$				0.1	mA
I _{IH}	HIGH Level Input Current	$V_{CC} = Max, V_I = 2.7$	7V			20	μА
I _{IL}	LOW Level Input Current	$V_{CC} = Max, V_I = 0.4$	4V			-0.2	mA
Ios	Short Circuit Output Current	V _{CC} = Max (Note 3))	-40		-225	mA
I _{CC}	Supply Current	$V_{CC} = Max$,	Outputs HIGH		13	23	
		Outputs OPEN	Outputs LOW		26	44	
			Outputs Disabled		27	46	mA
					29	50	
					32	32 54	

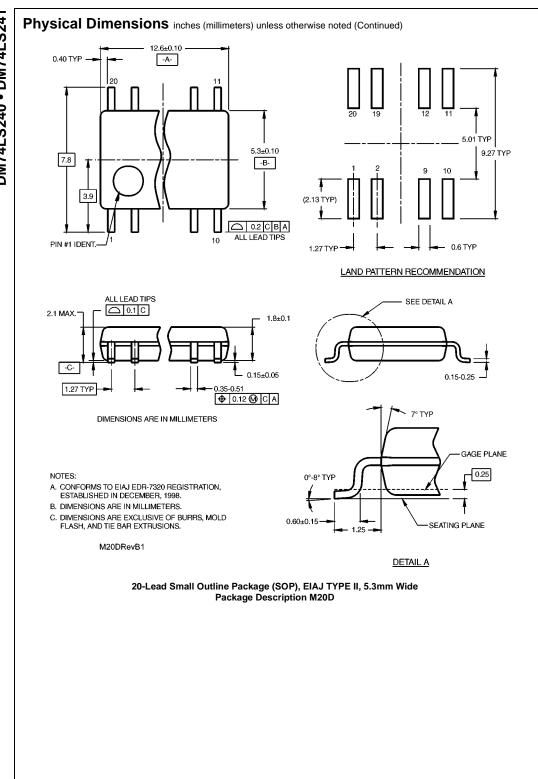
Note 2: All typicals are at V_{CC} = 5V, T_A = 25°C.

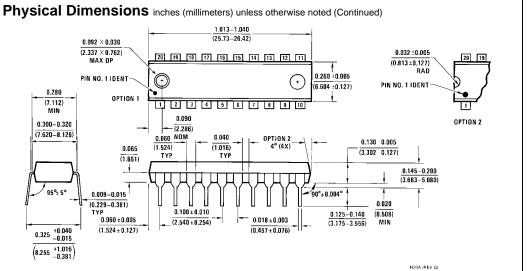
Note 3: Not more than one output should be shorted at a time, and the duration should not exceed one second.

Switching Characteristics at V_{CC} = 5V and T_A = 25°C

Symbol	Parameter		Conditions	Max	Units	
t _{PLH}	Propagation Delay Time	C _L = 45 pF	DM74LS240	14		
	LOW-to-HIGH Level Output	$R_L = 667\Omega$	DM74LS241	18	ns	
t _{PHL}	Propagation Delay Time	C _L = 45 pF	DM74LS240	18		
	HIGH-to-LOW Level Output	$R_L = 667\Omega$	DM74LS241	18	ns	
t _{PZL}	Output Enable Time	C _L = 45 pF	DM74LS240	30		
	to LOW Level	$R_L = 667\Omega$	DM74LS241	30	ns	
t _{PZH}	Output Enable Time	C _L = 45 pF	DM74LS240	23	ns	
	to HIGH Level	$R_L = 667\Omega$	DM74LS241	23	115	
t _{PLZ}	Output Disable Time	$C_L = 5 pF$	DM74LS240	25	ns	
	from LOW Level	$R_L = 667\Omega$	DM74LS241	25		
t _{PHZ}	Output Disable Time	C _L = 5 pF	DM74LS240	18	ns	
	from HIGH Level	$R_L = 667\Omega$	DM74LS241	18		
t _{PLH}	Propagation Delay Time	C _L = 150 pF	DM74LS240	18		
	LOW-to-HIGH Level Output	$R_L = 667\Omega$	DM74LS241	21	ns	
t _{PHL}	Propagation Delay Time	C _L = 150 pF	DM74LS240	22	ns	
	HIGH-to-LOW Level Output	$R_L = 667\Omega$	DM74LS241	22		
t _{PZL}	Output Enable Time	C _L = 150 pF	DM74LS240	33	ns	
	to LOW Level	$R_L=667\Omega$	DM74LS241	33	ns	
t _{PZH}	Output Enable Time	C _L = 150 pF	DM74LS240	26	no	
	to HIGH Level	$R_L = 667\Omega$	DM74LS241	26	ns	







20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N20A

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